查询IRL540PbF供应商

VISHAY

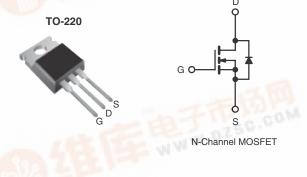
捷多邦,专业PCB打样工厂 ,24小时加急出货

IRL540, SiHL540

Vishay Siliconix

WWW.DZSC **Power MOSFET**

PRODUCT SUMMARY			
100			
$V_{GS} = 5.0 V$	0.077		
64			
9.4 00			
27			
Single			
	V _{GS} = 5.0 V 64 9.4 27		



FEATURES

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- Logic-Level Gate Drive
- R_{DS(on)} Specified at V_{GS} = 4 V and 5 V
- 175 °C Operating Temperature
- · Fast Switching
- · Ease of Paralleling
- Lead (Pb)-free Available

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220 contribute to its wide acceptance throughout the industry.

ORDERING INFORMATION	一一一万万四
Package	TO-220
Lead (Pb)-free	IRL540PbF
	SiHL540-E3
SnPb	IRL540
	SiHL540

ABSOLUTE MAXIMUM RATINGS To	$j = 20^{\circ}$ C, arriess otherw			1
PARAMETER	SYMBOL	LIMIT	UNIT	
Drain-Source Voltage	V _{DS}	100	V	
Gate-Source Voltage	V _{GS}	± 10	v	
Continuous Drain Current	V_{GS} at 5.0 V $T_C = 25 \degree C$		28	1111
Continuous Drain Current	V_{GS} at 5.0 V $T_C = 100 ^{\circ}C$	I _D	20	А
Pulsed Drain Current ^a	I _{DM}	110	COM	
Linear Derating Factor		Part Internet	1.0	W/°C
Single Pulse Avalanche Energy ^b		E _{AS}	440	mJ
Avalanche Current ^a	I _{AR}	28	A	
Repetitive Avalanche Energy ^a	509	E _{AR}	15	mJ
Maximum Power Dissipation	T _C = 25 °C	PD	150	W
Peak Diode Recovery dV/dtc	dV/dt	5.5	V/ns	
Operating Junction and Storage Temperature Range	T _J , T _{stg}	- 55 to + 175	°C	
Soldering Recommendations (Peak Temperature)	for 10 s		300 ^d	
Mounting Torque	6.00 or M0 oprovi		10	lbf ⋅ in
	6-32 or M3 screw	F	1.1	N · m

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. $V_{DD} = 25 \text{ V}$, starting $T_J = 25 \text{ °C}$, L = 841 µH, $R_G = 25 \Omega$, $I_{AS} = 28 \text{ A}$ (see fig. 12c). c. $I_{SD} \le 28 \text{ A}$, dl/dt $\le 170 \text{ A/µs}$, $V_{DD} \le V_{DS}$, $T_J \le 175 \text{ °C}$.

d. 1.6 mm from case.

Pb containing terminations are not RoHS compliant, exemptions may apply

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THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-	62		
Case-to-Sink, Flat, Greasd Surface	R _{thCS}	0.50	-	°C/W	
Maximum Junction-to-Case (Drain)	R _{thJC}	-	1.0		

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 V, I_D = 250 \mu A$		100	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_J$	Reference to 25 °C, I _D = 1 mA		-	0.12	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = 250 \ \mu A$		1.0	-	2.0	V
Gate-Source Leakage	I _{GSS}	$V_{GS} = \pm 10 V$		-	-	± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 100 V, V _{GS} = 0 V		-	-	25	μΑ
		$V_{DS} = 80 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 150 ^{\circ}\text{C}$		-	-	250	
Drain-Source On-State Resistance	R _{DS(on)}	$V_{GS} = 5.0 V$	I _D = 17 A ^b	-	-	0.077	Ω
		$V_{GS} = 4.0 V$	I _D = 14 A ^b	-	-	0.11	
Forward Transconductance	g _{fs}	V _{DS} = 50 V, I _D = 17 A		12	-	-	S
Dynamic							
Input Capacitance	Ciss	$V_{GS} = 0 V, V_{DS} = 25 V, f = 1.0 MHz, see fig. 5$		-	2200	-	pF
Output Capacitance	C _{oss}			-	560	-	
Reverse Transfer Capacitance	C _{rss}			-	140	-	
Total Gate Charge	Qg			-	-	64	nC
Gate-Source Charge	Q_gs	$V_{GS} = 5.0 V$	I _D = 28 A, V _{DS} = 80 V, see fig. 6 and 13 ^b	-	-	9.4	
Gate-Drain Charge	Q _{gd}			-	-	27	
Turn-On Delay Time	t _{d(on)}			-	8.5	-	
Rise Time	t _r	V_{DD} = 50 V, I _D = 28 A, R _G = 9.0 Ω, R _D = 1.7 Ω, see fig. 10 ^b		-	170	-	- ns
Turn-Off Delay Time	t _{d(off)}			-	35	-	
Fall Time	t _f			-	807	-	
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	nH
Internal Source Inductance	L _S			-	7.5	-	
Drain-Source Body Diode Characteristic	S						
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	28	А
Pulsed Diode Forward Current ^a	I _{SM}			-	-	110	
Body Diode Voltage	V_{SD}	T_J = 25 °C, I_S = 28 A, V_{GS} = 0 V ^b		-	-	2.5	V
Body Diode Reverse Recovery Time	t _{rr}	- $T_J = 25 \text{ °C}, I_F = 28 \text{ A}, \text{ dl/dt} = 100 \text{ A/}\mu\text{s}^b$		-	200	260	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	1.7	2.90	μC
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L_S and L_D)				_D)	

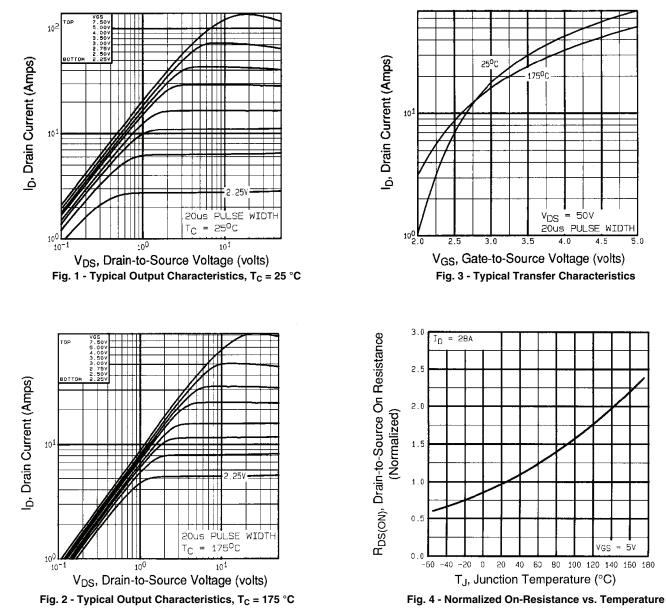
Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width \leq 300 µs; duty cycle \leq 2 %.



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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

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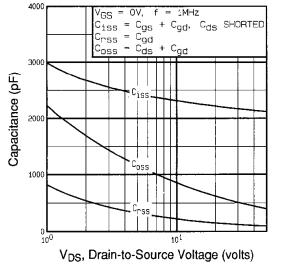


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

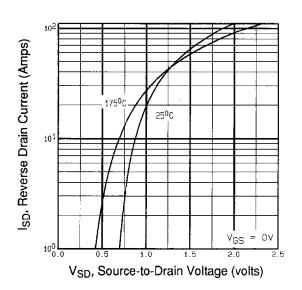


Fig. 7 - Typical Source-Drain Diode Forward Voltage

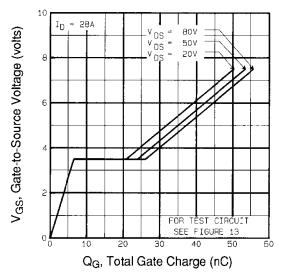


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

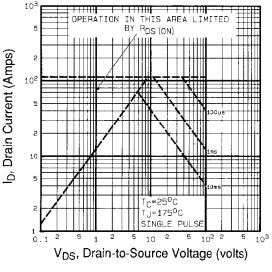


Fig. 8 - Maximum Safe Operating Area



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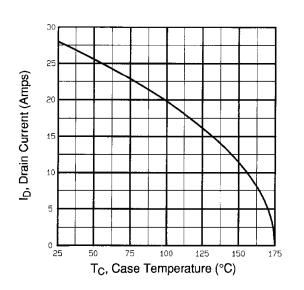


Fig. 9 - Maximum Safe Operating Area

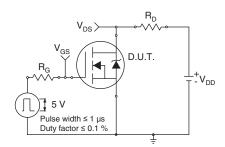


Fig. 10a - Switching Time Test Circuit

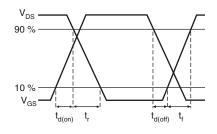


Fig. 10b - Switching Time Waveforms

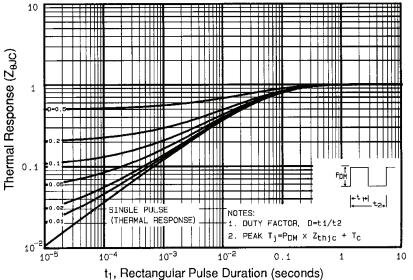


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

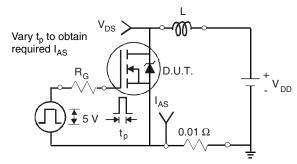


Fig. 12a - Unclamped Inductive Test Circuit

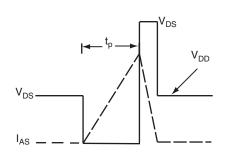


Fig. 12b - Unclamped Inductive Waveforms

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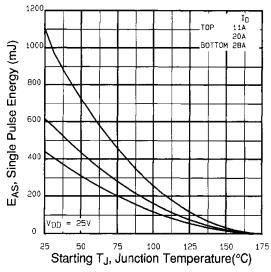


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

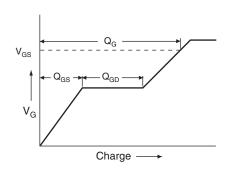


Fig. 13a - Basic Gate Charge Waveform

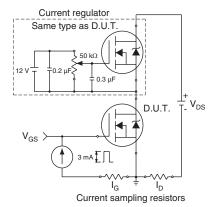
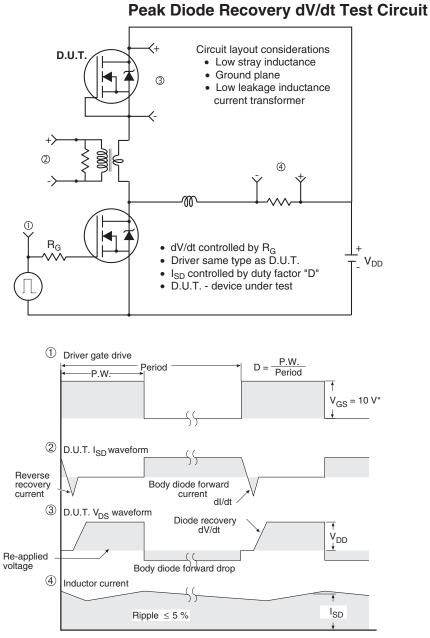


Fig. 13b - Gate Charge Test Circuit



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* $V_{GS} = 5 V$ for logic level devices

Fig. 14 - For N-Channel

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